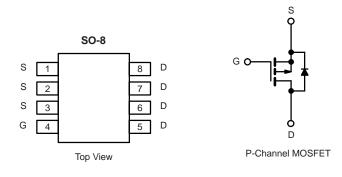
P-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)			
- 40	0.010 at V_{GS} = - 10 V	- 16.1	33 nC			
- 40	0.014 at V _{GS} = - 4.5 V	- 13.3	33110			



FEATURES

- 100 % Rg Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

 Load Switch POL



ABSOLUTE MAXIMUM RATIN	IGS T _A = 25 °C,	unless othe	erwise noted	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 40	V	
Gate-Source Voltage		V _{GS}	± 20	V
	T _C = 25 °C		- 16.1	
Continuous Drain Current (T 150 °C)	T _C = 70 °C		- 12.9	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 10.2 ^{b, c}	
	T _A = 70 °C		- 8.2 ^{b, c}	A
Pulsed Drain Current		I _{DM}	- 50	A
Continous Source-Drain Diode Current	T _C = 25 °C		- 5.3	
	T _A = 25 °C	I _S	- 2.1 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 28	
Single Pulse Avalanche Energy		E _{AS}	39	mJ
	T _C = 25 °C		6.3	
Movimum Power Dissipation	T _C = 70 °C		4	w
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{b, c}	vv
	T _A = 70 °C	1	1.6 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS							
	Symbol	Typical	Maximum	Unit			
t ≤ 10 s	R _{thJA}	37	50	°C/W			
Steady State	R _{thJF}	16	20	0/10			
	t ≤ 10 s	$\begin{array}{c c} & \textbf{Symbol} \\ \hline t \le 10 \text{ s} & \textbf{R}_{\text{thJA}} \end{array}$	SymbolTypical $t \le 10 \text{ s}$ R_{thJA} 37	$\begin{tabular}{ c c c c c c c } \hline $Symbol & Typical & Maximum \\ \hline $t \le 10 $ s & R_{thJA} & 37 & 50 \\ \hline \end{tabular}$			

Notes:

a. Based on $T_C = 25$ °C. b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under steady state conditions is 85 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	- Ι _D = - 250 μΑ		- 36		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i _D = - 250 μA		5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	- 1.2		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zana Osta Maltana Dasia Osmaal	I _{DSS}	V _{DS} = - 40 V, V _{GS} = 0 V			- 1	μA	
Zero Gate Voltage Drain Current		$V_{DS} = -40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 10 V	- 25			Α	
	D	V _{GS} = - 10 V, I _D = - 10.2 A		0.010		0	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 8.4 A		0.014		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 10.2 A		37		S	
Dynamic ^b	<u> </u>			<u> </u>	I		
Input Capacitance	C _{iss}			3007		pF	
Output Capacitance	C _{oss}	V _{DS} = - 20 V, V _{GS} = 0 V, f = 1 MHz		335			
Reverse Transfer Capacitance	C _{rss}			291			
Total Gate Charge	Qg	$V_{DS} = -20 \text{ V}, \text{ V}_{GS} = -10 \text{ V}, \text{ I}_{D} = -10.2 \text{ A}$		64 9	95	nC	
				33	50		
Gate-Source Charge	Q _{gs}	V_{DS} = - 20 V, V_{GS} = - 4.5 V, I_D = - 10.2 A		9.8			
Gate-Drain Charge	Q _{gd}			15.7			
Gate Resistance	Rg	f = 1 MHz	0.4	2	4	Ω	
Turn-On Delay Time	t _{d(on)}			57	86		
Rise Time	t _r	V_{DD} = - 20 V, R_L = 2.4 Ω		50	75	- ns	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 8.2 A, V_GEN = - 4.5 V, R_g = 1 Ω		40	60		
Fall Time	t _f			17	26		
Turn-On Delay Time	t _{d(on)}			13	20		
Rise Time	t _r	V_{DD} = - 20 V, R_L = 2.4 Ω		11	20		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 8.2 A, V_GEN = - 10 V, R_g = 1 Ω		45	68		
Fall Time	t _f			9	18		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 5.3	٨	
Pulse Diode Forward Current	I _{SM}				- 50	A	
Body Diode Voltage	V _{SD}	I _S = - 8.2 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			36	54	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$\frac{Q_{rr}}{t_a}$ I _F = - 8.2 A, dl/dt = 100 A/µs, T _J = 25 °C		41	62	nC	
Reverse Recovery Fall Time				20		ns	
Reverse Recovery Rise Time	t _b			16			

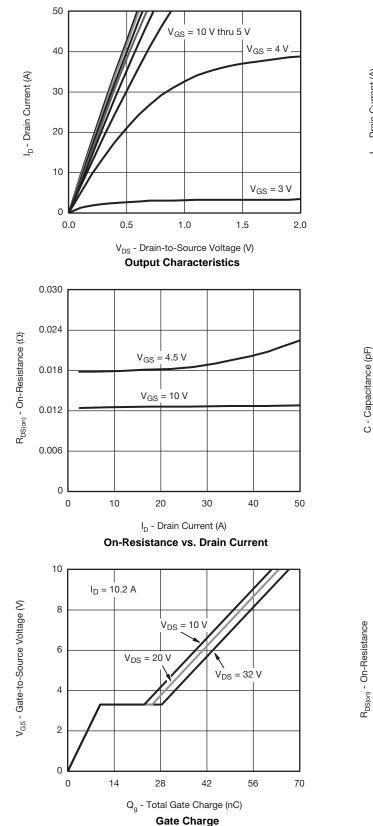
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

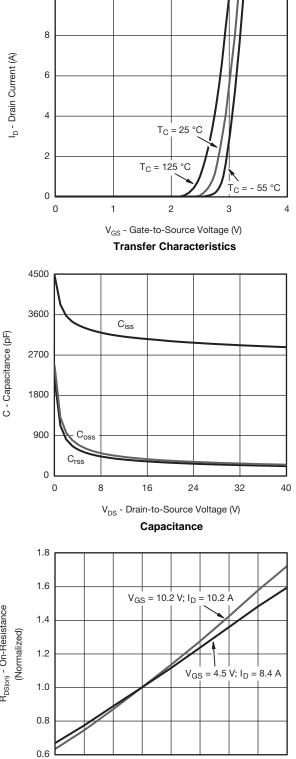
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



10

T_J - Junction Temperature (°C) On-Resistance vs. Junction Temperature

75

100

125

150

50

- 50

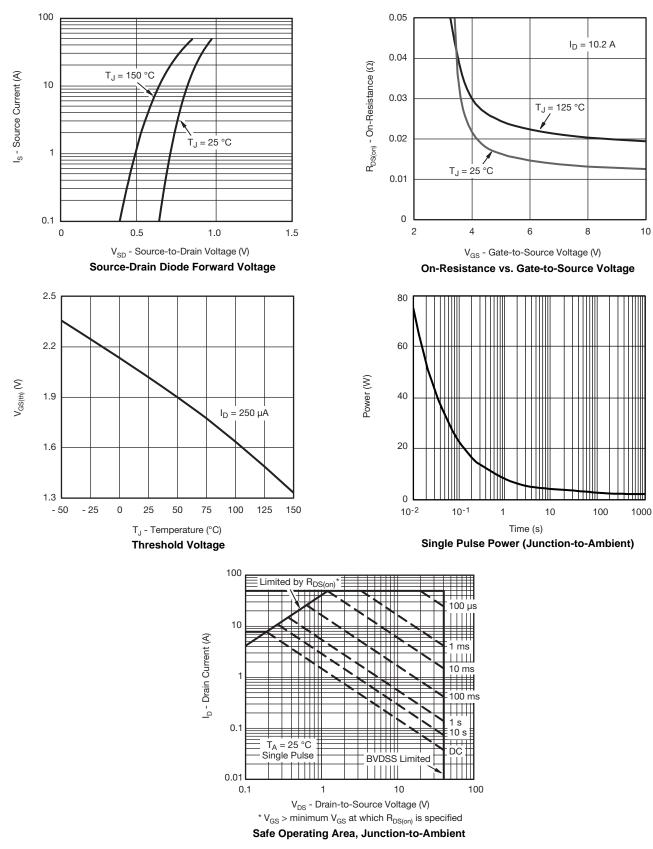
- 25

0

25



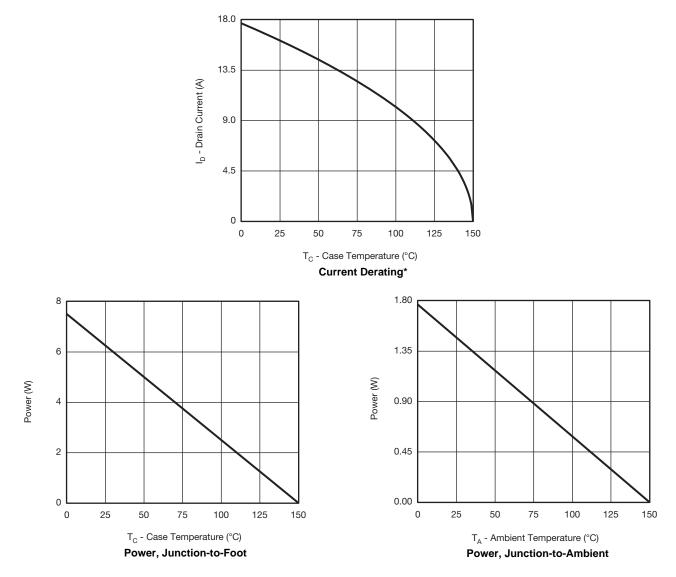
10



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

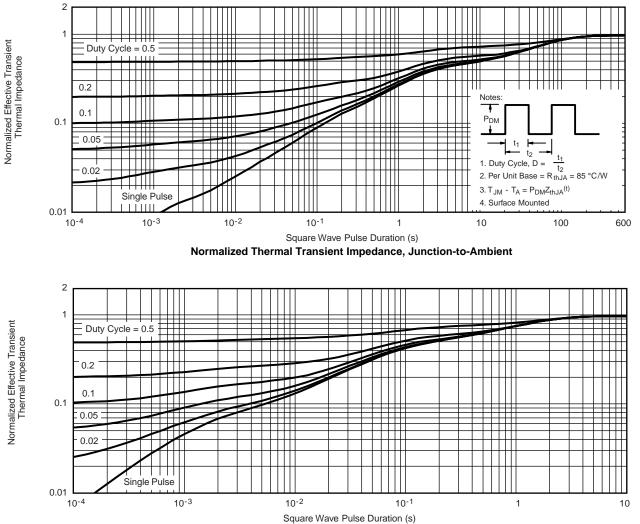


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Foot

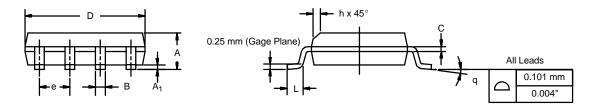


Package Information www.din-tek.jp

SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

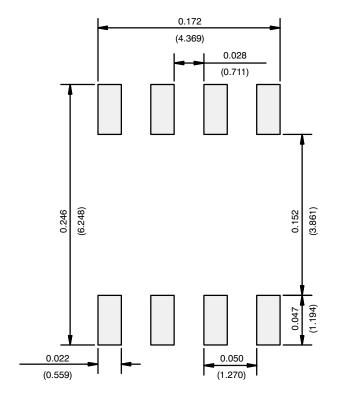




	MILLIM	IETERS	INC	HES	
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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